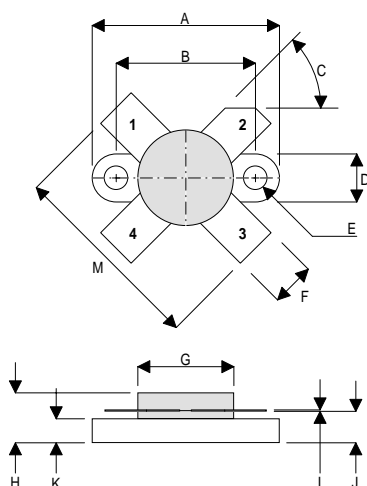


MECHANICAL DATA

GOLD METALLISED MULTI-PURPOSE SILICON DMOS RF FET 30W – 12.5V – 175MHz SINGLE ENDED



DM

PIN 1 SOURCE PIN 2 DRAIN
PIN 3 SOURCE PIN 4 GATE

| DIM | mm | Tol. | Inches | Tol. |
|-----|----------|------|-----------|-------|
| A | 24.76 | 0.13 | 0.975 | 0.005 |
| B | 18.42 | 0.13 | 0.725 | 0.005 |
| C | 45° | 5° | 45° | 5° |
| D | 6.35 | 0.13 | 0.25 | 0.005 |
| E | 3.17 Dia | 0.13 | 0.125 Dia | 0.005 |
| F | 5.71 | 0.13 | 0.225 | 0.005 |
| G | 12.7 Dia | 0.13 | 0.500 Dia | 0.005 |
| H | 6.60 | REF | 0.260 | REF |
| I | 0.13 | 0.02 | 0.005 | 0.001 |
| J | 4.32 | 0.13 | 0.170 | 0.005 |
| K | 3.17 | 0.13 | 0.125 | 0.005 |
| M | 26.16 | 0.25 | 1.03 | 0.010 |

FEATURES

- SIMPLIFIED AMPLIFIER DESIGN
- SUITABLE FOR BROAD BAND APPLICATIONS
- LOW C_{rss}
- LOW NOISE
- HIGH GAIN – 10 dB MINIMUM

APPLICATIONS

- HF/VHF/UHF COMMUNICATIONS
from 1 MHz to 200MHz

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^{\circ}C$ unless otherwise stated)

| | | |
|--------------|--|-------------------------|
| P_D | Power Dissipation | 117W |
| BV_{DSS} | Drain – Source Breakdown Voltage | 40V |
| BV_{GSS} | Gate – Source Breakdown Voltage | $\pm 20V$ |
| $I_{D(sat)}$ | Drain Current | 30A |
| T_{stg} | Storage Temperature | -65 to $150^{\circ}C$ |
| T_j | Maximum Operating Junction Temperature | $200^{\circ}C$ |

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

ELECTRICAL CHARACTERISTICS (T_{case} = 25°C unless otherwise stated)

| Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--|---|------|------|------|------|
| BV _{DSS} Drain–Source Breakdown Voltage | V _{GS} = 0 I _D = 100mA | 40 | | | V |
| I _{DSS} Zero Gate Voltage Drain Current | V _{DS} = 12.5V V _{GS} = 0 | | | 1 | mA |
| I _{GSS} Gate Leakage Current | V _{GS} = 20V V _{DS} = 0 | | | 1 | μA |
| V _{GS(th)} Gate Threshold Voltage* | I _D = 10mA V _{DS} = V _{GS} | 1 | | 7 | V |
| g _{fs} Forward Transconductance* | V _{DS} = 10V I _D = 3A | 2.4 | | | S |
| G _{PS} Common Source Power Gain | P _O = 30W | 10 | | | dB |
| η Drain Efficiency | V _{DS} = 12.5V I _{DQ} = 0.6A | 50 | | | % |
| VSWR Load Mismatch Tolerance | f = 175MHz | 20:1 | | | — |
| C _{iss} Input Capacitance | V _{DS} = 0 V _{GS} = –5V f = 1MHz | | | 180 | pF |
| C _{oss} Output Capacitance | V _{DS} = 12.5V V _{GS} = 0 f = 1MHz | | | 120 | pF |
| C _{rss} Reverse Transfer Capacitance | V _{DS} = 12.5V V _{GS} = 0 f = 1MHz | | | 12 | pF |

* Pulse Test: Pulse Duration = 300 μs , Duty Cycle ≤ 2%

HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and metal flange is beryllium oxide. Beryllium oxide dust is highly toxic and care must be taken during handling and mounting to avoid damage to this area.

THESE DEVICES MUST NEVER BE THROWN AWAY WITH GENERAL INDUSTRIAL OR DOMESTIC WASTE.

THERMAL DATA

| | | |
|-----------------------|------------------------------------|----------------|
| R _{THj-case} | Thermal Resistance Junction – Case | Max. 1.5°C / W |
|-----------------------|------------------------------------|----------------|

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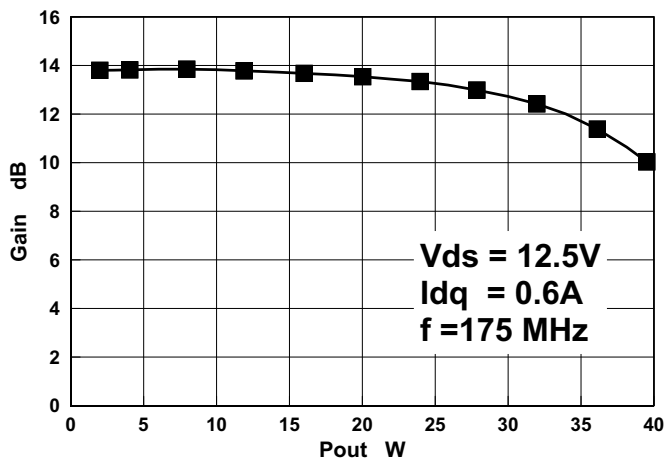


Figure 1- Gain vs. Power Output

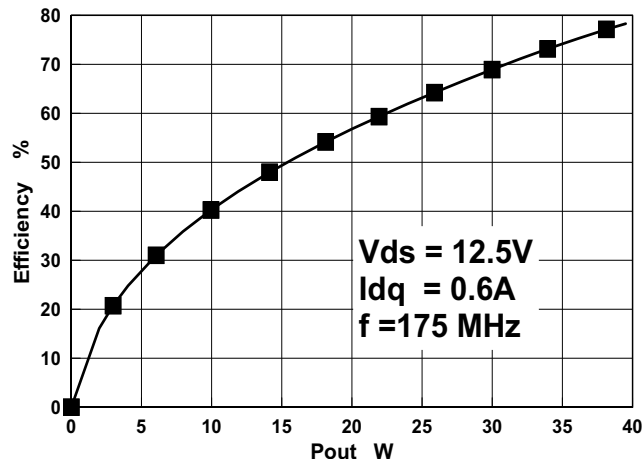


Figure 2 - Efficiency vs Power Output

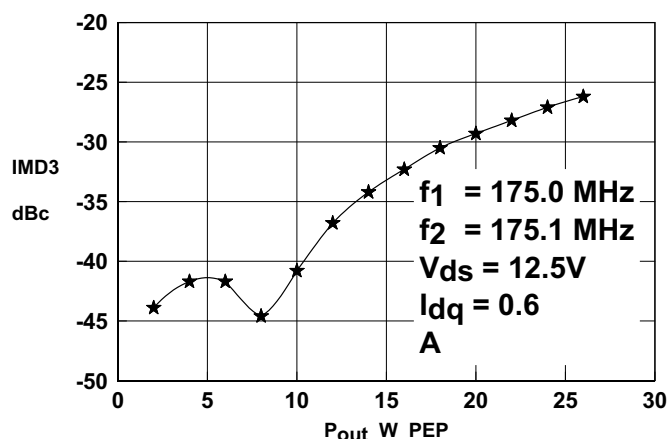


Figure 3 - IMD vs Power Output

Typical S Parameters

! $V_{DS} = 12.5V$, $I_{DQ} = 0.6A$
 # MHz S MA R 50

| Freq MHz | S11 | | S21 | | S12 | | S22 | |
|-------------|------|--------|------|------|-------|------|------|--------|
| | mag | ang | mag | ang | mag | ang | mag | ang |
| 50 | 0.78 | -167.2 | 17.2 | 76.0 | 0.011 | 0.0 | 0.72 | -164.2 |
| 100 | 0.82 | -171.7 | 7.7 | 57.9 | 0.008 | 3.9 | 0.78 | -167.6 |
| 150 | 0.87 | -174.9 | 4.5 | 44.5 | 0.006 | 31.6 | 0.84 | -170.3 |
| 200 | 0.90 | -178.2 | 2.9 | 34.2 | 0.008 | 63.1 | 0.88 | -173.3 |
| 250 | 0.93 | 178.6 | 2.0 | 26.2 | 0.012 | 75.9 | 0.91 | -176.2 |
| 300 | 0.94 | 175.4 | 1.5 | 19.9 | 0.016 | 79.6 | 0.93 | -178.9 |
| 350 | 0.96 | 172.5 | 1.1 | 14.8 | 0.020 | 80.1 | 0.95 | 178.5 |
| 400 | 0.96 | 169.6 | 0.9 | 10.5 | 0.025 | 79.2 | 0.96 | 176.1 |
| 450 | 0.97 | 166.9 | 0.7 | 7.1 | 0.029 | 77.7 | 0.97 | 173.8 |
| 500 | 0.97 | 164.3 | 0.6 | 4.2 | 0.033 | 76.0 | 0.97 | 171.7 |

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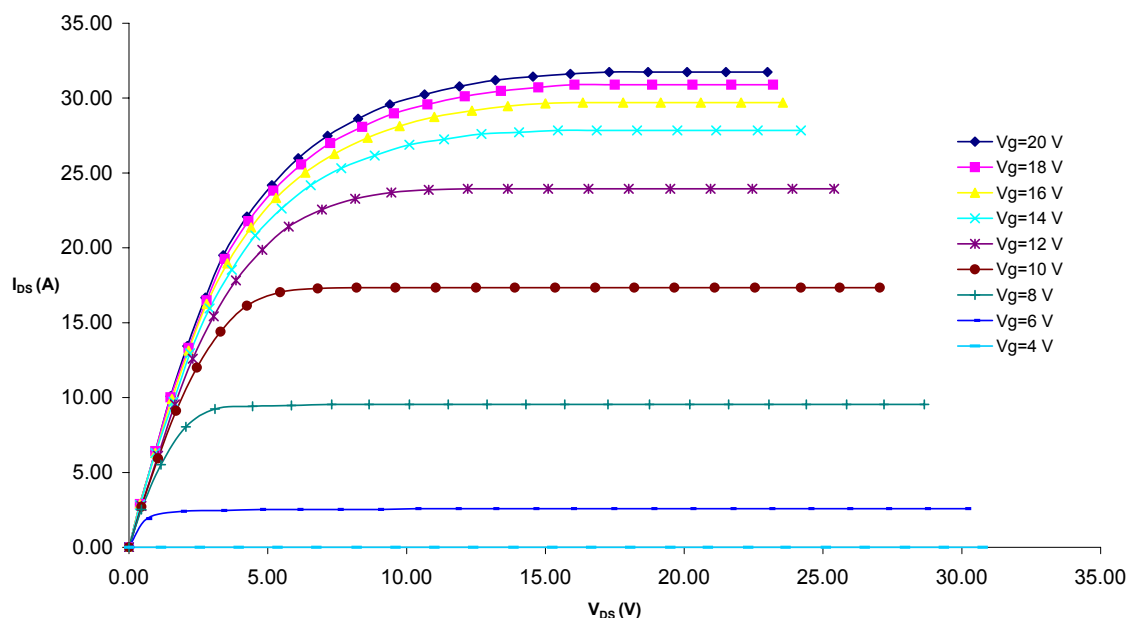


Figure 4 – Typical IV Characteristics.

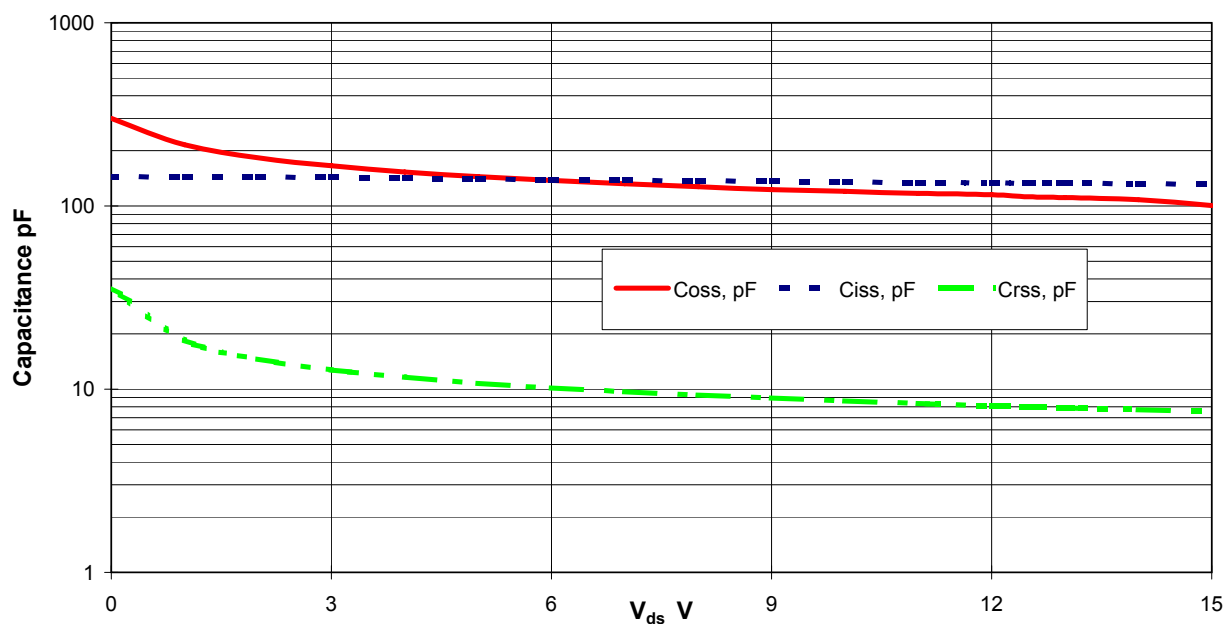
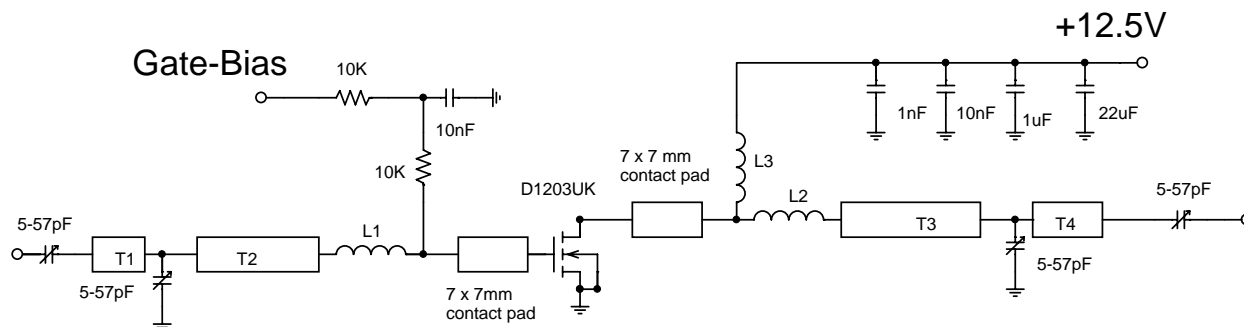


Figure 5 – Typical CV Characteristics.



D1203UK 175MHz TEST FIXTURE

Substrate 1.6mm PTFE/glass, $\epsilon_r=2.5$

All microstrip lines $W=4.4\text{mm}$

T1 8mm

T2 22mm

T3 18mm

T4 4.5mm

L1 Hairpin loop 16swg 15.5mm dia

L2 Hairpin loop 16swg 10mm dia

L3 11 turns 18swg enamelled copper wire, 10mm i.d.